
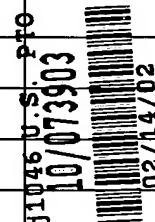


FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. H-1024		SERIAL NO.	
<b>LIST OF DOCUMENTS CITED BY APPLICANT</b> <i>(Use several sheets if necessary)</i>				APPLICANT A. KOIZUMI et al		GROUP	
				FILING DATE February 14, 2002			
<b>U.S. PATENT DOCUMENTS</b>							
* EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE <i>(If Appropriate)</i>	
	AA						
	AB						
	AC						
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	AG						
	AH						
	AI						
	AJ						
	AK						
<b>FOREIGN PATENT DOCUMENTS</b>							
	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
MF	AL	9-65424	3/7/97	Japan		<input type="checkbox"/>	<input type="checkbox"/>
MF	AM	56-88564	7/17/81	Japan		<input type="checkbox"/>	<input type="checkbox"/>
	AN					<input type="checkbox"/>	<input type="checkbox"/>
	AO					<input type="checkbox"/>	<input type="checkbox"/>
	AP					<input type="checkbox"/>	<input type="checkbox"/>
<b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
MF	AR	"Fundamentals of Speech Recognition" Vol 2., L. Rabiner et al, translation supervised by Sadaki Furui, NTT Advance Technology, 1995,					
		pp. 245-304.					
MF	AS	"From Text to Speech", J. Alien et al, Cambridge University Press, 1987, pp. 16-150.					
MF	AT	"Recent Situations of the Text-to-Speech Synthesis Technology", Interface, Dec. 1996, Yatou, pp. 161-165.					
EXAMINER 				DATE CONSIDERED 10-25-04			
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10/073,903**LIST OF DOCUMENTS CITED BY APPLICANT**  
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MF	AL	08-328585	12/13/96	Japan (w English Abstract)			<input type="checkbox"/>	<input type="checkbox"/>
MF	AM	58-40684	03/09/96	Japan			<input type="checkbox"/>	<input type="checkbox"/>
	AN						<input type="checkbox"/>	<input type="checkbox"/>
	AO						<input type="checkbox"/>	<input type="checkbox"/>
	AP						<input type="checkbox"/>	<input type="checkbox"/>

**OTHER DOCUMENTS** (Including Author, Title, Date, Pertinent Pages, etc.)

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